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## PAPER



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## 1. Introduction

Among the several semiconducting oxide materials, zinc oxide (ZnO) has gained widespread popularity due to its demonstrated applications in several areas including optoelectronics, such as solid state light emitting devices (LEDs), gas sensors, piezoelectric transducers, optical waveguides, ultra violet (UV) laser emitters, solar cells, *etc.*<sup>1–3</sup> ZnO is a wide bandgap semiconductor with an  $E_g$  around 3.37 eV and the photoluminescence spectrum of ZnO exhibits a near-band-edge UV emission and a broad defect-related visible emission, prominently in the green region due to the presence of oxygen defects. It is anticipated that the luminescence properties of ZnO nanophosphors (NPs) could be tailored by doping with different luminescent centers. In addition, ZnO is known to exhibit a magnetic behavior showing ferromagnetism (FM) at room temperature (RT) that is stable even above 600 °C.

In the present work the ZnO NPs were doped with increasing amounts of  $Eu^{3+}$  from 0.01 to 0.25 M% with the aim of obtaining red emission. It was observed that along with the sharp red emission line intensity, the RTFM that existed in

# Probing high temperature ferromagnetism and its paramagnetic phase change due to Eu<sup>3+</sup> incorporation in ZnO nanophosphors

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Ferromagnetic oxide semiconductors exhibiting efficient luminescent properties together with robust ferromagnetism above room temperature form an exclusive class of spintronic materials endowed with both charge and spin degrees of freedom. Herein, we report on the occurrence of high temperature ferromagnetism (>600 K) in zinc oxide nanophosphors attributed to the presence of defects in the host lattice and wherein incorporation of rare earth ions contributed to a gradual reduction in the ferromagnetic character and steady transformation to paramagnetic behavior. Although undoped ZnO nanophosphors exhibit a high coercive field and saturation magnetization along with a prominent green emission (536 nm) attributed to the presence of oxygen vacancies  $V_o$ , Eu<sup>3+</sup> doping results in a decrease in green emission along with coercivity as well as magnetization efficient line emission in the orange red region (618–622 nm) pointing to a definite correlation between the  $V_o$  and ferromagnetism. The temperature dependence of the magnetization shows stable ferromagnetism with Curie temperature above 600 K for undoped ZnO and a ferromagnetic to paramagnetic transition with an increase in Eu<sup>3+</sup> concentration that has been explained through an F<sup>+</sup> center exchange mechanism.

undoped ZnO NPs decreased in terms of coercivity and saturation magnetization with increasing  $Eu^{3+}$  concentration. Further at a particular  $Eu^{3+}$  concentration in the ZnO NPs a definite ferromagnetic to paramagnetic transition is observed. The present studies are aimed at understanding this variation in the magnetic properties of ZnO NPs with  $Eu^{3+}$  incorporation along with the red emission and establish a correlation between these two phenomena, if it exists.

Thus far, diverse magnetic properties have been reported in ZnO based dilute magnetic semiconductors (DMS)4-7 and in particular for the case of RTFM there are several theoretical models that have been predicted to explain the coupling responsible.8-10 However, the origin of such a FM has yet to be uncovered, and the mechanism behind the magnetic ordering is still under debate. In a few cases it has been demonstrated that the magnetism was due to segregation of metallic clusters<sup>11</sup> while in others that include transition elements with variable valence states (Mn<sup>3+</sup> and Mn<sup>4+</sup>), it was attributed to the double exchange phenomenon.<sup>12,13</sup> The main challenge in these materials that holds promise in a technological perspective is to retain the magnetic character above RT, that is, Curie temperature  $(T_{\rm C})$  above 300 K, and overcome the primary limitation that is associated with the non homogeneity in the solubility of magnetic ions in the semiconductor lattice. Some recent reports on this topic suggest that the magnetic properties are not exclusively related to the presence of the magnetic ions but are strongly determined by the defects.9,14-17 In recent times studies

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Fig. 1 Shown are the steps for the synthesis of ZnO: $Eu^{3+}$  NPs. Step 1: the mixture of host, activator and fuel (zinc acetate dihydrate + europium III acetate hydrate + urea) at RT; step 2: auto combustion on a preheated furnace at the temperature of 450 °C for 2 h; step 3: fluff formation of combusted sample; step 4: calcination at the temperature of 400 °C for 2 h; step 5: the final product formation.

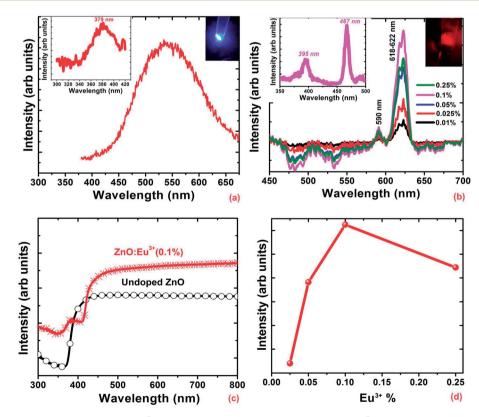
on nonmagnetic doped<sup>18,19</sup> and undoped ZnO<sup>20-23</sup> systems indicate that the magnetic properties may not be solely related to the presence of the magnetic ions but are strongly mediated by the point defects, such as oxygen vacancies  $(V_{\rm Zn})^{24}$  and Zn interstitials  $(Zn_i)$ .<sup>22</sup> Due to the complexity of defect states in ZnO like systems it is still a challenge to establish a definite correlation between the magnetization and the defects.

To date, there are some reports on the magnetic properties of rare earth elements such as gadolinium, terbium and erbium correlated to defects and dopant ions.<sup>25,26</sup> The present paper is an attempt to identify the role of yet another rare earth ion Eu<sup>3+</sup> and the defects present in the ZnO lattice which could be responsible for the observed luminescence and ferromagnetism, the mechanism responsible for the paramagnetic phase

change at different  $\mathrm{Eu}^{3+}$  concentration, and to establish a correlation between them.

## 2. Experimental details

ZnO NPs doped with  $Eu^{3+}$  (0.01–0.25 M%) are synthesized *via* a solid combustion technique (SCT) using zinc acetate as host precursor, europium(m) acetate hexahydrate as activator and urea as fuel. A schematic of the SCT synthesis process is presented in Fig. 1. A beaker containing host and activator precursors and fuel prepared at RT is placed in a preheated furnace at 450 °C for 10–15 min. Care was taken to avoid any metallic tools during the synthesis to preclude any inadvertent contamination. A fluffy mass filled the beaker as shown, that was crushed to powder and fired at 400 °C for 2 h. To identify



**Fig. 2** Spectroscopic investigation of the ZnO: $Eu^{3+}$  NPs. PL studies of the (a) undoped (b)  $Eu^{3+}$  doped ZnO NPs. Excitation spectrum and fluorescent images of undoped and ZnO: $Eu^{3+}$  (0.1 M%) NPs shown in corresponding insets. Absorption spectra and variation in PL intensity due to incorporation of  $Eu^{3+}$  in ZnO has been shown in figures (c) and (d).

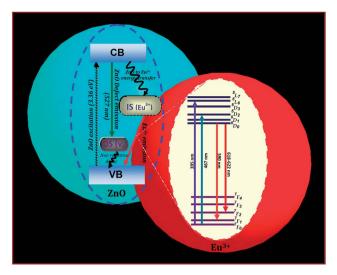


Fig. 3 Photoluminescence mechanism of  $ZnO:Eu^{3+}$  NPs. Schematic illustration of possible excitation and emission mechanism of undoped and  $Eu^{3+}$  doped ZnO NPs.

the optimum phase formation temperature, the material was subjected to increasing synthesis temperatures (200, 400 and 600  $^{\circ}$ C) and the crystallinity and phase monitored by X-ray diffraction (XRD).

## 3. Characterization

Photoluminescence (PL) spectra of undoped and Eu<sup>3+</sup> powder samples were recorded using an Edinburgh Instruments FLSP920 steady state spectrometer with a xenon lamp source. Magnetization versus magnetic field (M-H) was measured using Micro-sense vibrating sample magnetometer EV9 (VSM) using an electromagnet as a magnetic field source, argon gas during increasing temperature and nitrogen gas during cooling. The VSM instrument has a capability of scanning temperature in the range of 77 K to 600 K and a RMS sensitivity of  $10^{-6}$  emu g<sup>-1</sup>. The VSM is equipped with a Crest Performance CPX 900 Power amplifier, a Stanford Research Systems Model SR830 DSP Lock-in-Amplifier and a Model 32KP Gaussmeter. A quartz rod wrapped with aluminium foil was used as the sample holder to prevent any magnetic contamination. The surface magnetic domain pattern of the NPs was performed at RT using magnetic force microscopy (MFM) module in a scanning probe microscope from NT-MDT (Model-Aura, Russia) in semi-contact mode. Silicon cantilevers (NSG-01/Co from NT-MDT) coated with cobalt/chromium film having coating thickness 30-40 nm, tip radius  $\sim$ 40 nm and resonance frequency 222 kHz were used. The electron paramagnetic resonance (EPR) spectra were acquired on a JEOL (JES-FA 200) X-band spectrometer operating at 9.45 GHz (microwave frequency) and 100 kHz (modulation frequency) at RT.

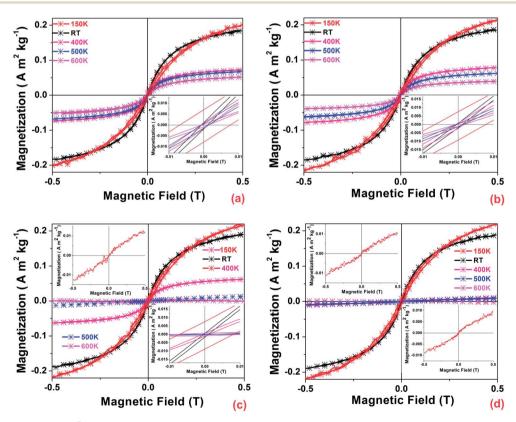


Fig. 4 Magnetic properties of  $Eu^{3+}$  doped ZnO NPs. Temperature related VSM plots of (a) undoped (b) 0.01 M% (c) 0.1 M% (d) 0.25 M% of  $Eu^{3+}$  doped ZnO NPs shows change in magnetization (ferromagnetic to paramagnetic) by increasing the temperature at higher  $Eu^{3+}$  concentration. The insets in the bottom of figures (a)–(c) shows the magnified view of corresponding NPs to show coercive field. The insets in the top of figure (c), top and bottom of figure (d) shows the magnified view of the paramagnetic properties of the ZnO: $Eu^{3+}$  NPs at 600 K (figure (c)), 500 and 600 K (figure (d)).

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Crystallographic phase identification was accomplished by powder X-ray diffraction on a PANalytical (Empyrean) Advance diffractometer and data were analyzed using the Rietveld refinement program. The morphological evaluation of the ZnO:Eu<sup>3+</sup> NPs were studied on a field emission scanning electron microscope (FESEM) (JEOL JSM-7610F) and the composition and elemental mapping was established by energy dispersive spectroscopy (EDS) attached to the FESEM instrument to see the effect of doping on the morphology as well as to reveal the presence of magnetic impurity if any. The X-ray photo electron spectroscopy (XPS) data was obtained using SPECS XPS system (M/s. SPECS Surface Nano Analysis GmbH, Germany) equipped with twin anode X-ray source and a hemispherical analyzer with a single-channel detector. The spectra were obtained using a 150 W non-monochromatic Al K $\alpha$  radiation (1486.6 eV).

### 4. Results and Discussion

To highlight the major outcome from this work, luminescence and temperature dependent magnetic studies of Eu<sup>3+</sup> doped ZnO NPs has been presented in the first part of the manuscript and the necessary supporting data in the form of structural, morphological and compositional evaluations are dealt with subsequently.

#### 4.1 Photoluminescence observations

RT PL excitation and emission spectra of undoped and Eu<sup>3+</sup> doped ZnO NPs are shown in Fig. 2a and b. The undoped ZnO shows a near-band-edge UV absorption peak due to crosswise band gap excitation of ZnO at 379 nm [inset of Fig. 2a (LHS)] with the prominent broadband green emission peak around 536 nm [Fig. 2a]. The fluorescence excitation image of the undoped powder under 379 nm irradiation is shown in the inset of Fig. 2a (RHS) and this green peak of undoped ZnO is attributed solely to the radiative recombination of photogenerated holes with electrons attributed to  $V_0$ .<sup>27-29</sup> In contrast, when Eu<sup>3+</sup> is doped into ZnO, the observed PL are the characteristic of Eu<sup>3+</sup> transitions. The excitation monitored on 395 nm due to  $^7F_0 \rightarrow \ ^5L_6$  transition and 467 nm due to  $^7F_0 \rightarrow$ <sup>5</sup>D<sub>2</sub> transition of Eu<sup>3+</sup> ions exhibit a sharp and strong orange red emission at 618 and 622 nm along with very low intensity peak at 590 nm related to the direct intra-4f transitions in Eu<sup>3+</sup> ions and low intensity green band emission at 535 nm due to

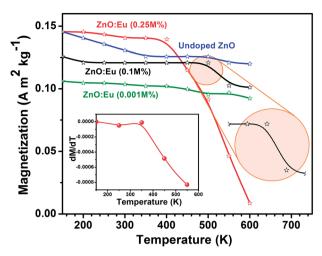


Fig. 5 Temperature dependent magnetic properties of Eu<sup>3+</sup> doped ZnO NPs. Temperature related magnetization plots of undoped and Eu<sup>3+</sup> doped ZnO NPs shows the Curie temperature and transition in magnetization (ferromagnetic to paramagnetic) at higher Eu<sup>3+</sup> concentration. The inset (LHS) shows the d*M*/d*T* curves, which indicated the *T*<sub>C</sub> of 550 K.

the intrinsic defects of ZnO host probably attributed to  $V_o$ , as inferred from the PL analysis of undoped ZnO. This latter conclusion gains credence from the observation that the PL intensity decreases for increasing Eu<sup>3+</sup> concentration since the increasing Eu<sup>3+</sup> corresponds directly to a decrease in  $V_o$ . PL emission increased with increase in Eu<sup>3+</sup> concentration up to 0.1 M% and beyond that a decrease was observed with increasing Eu<sup>3+</sup> concentration (Fig. 2d) justifying the choice of 0.1 M% Eu<sup>3+</sup> as the optimum composition for further characterization.

The major and sharp luminescence line at 618 nm is associated with the  ${}^{5}D_{0} \rightarrow {}^{7}F_{2}$  transitions of Eu<sup>3+</sup> ions, due to allowed electric-dipole transitions with inversion antisymmetry,<sup>30,31</sup> which results in a large transition probability in the crystal field. In ZnO:Eu<sup>3+</sup> NPs, the observed emission at 618 nm was split into two components at 618 and 622 nm. Theoretically, the  ${}^{7}F_{2}$  level gives three crystal field levels of 2E with  $3C_{v}$  symmetry and A1, but because of the close proximity of 2E levels and A1 it is quite probable that the two emission peaks (E and A1 at 618 and 622 nm) could have overlapped in the PL spectra.<sup>32,33</sup>

**Table 1** Magnetic properties, namely coercive field ( $H_c$ ) and magnetization (M) values, of different Eu<sup>3+</sup> doped ZnO NPs measured at various temperatures. The units of  $H_c$  and M are A m<sup>-1</sup> and A m<sup>2</sup> kg<sup>-1</sup>, respectively. 'PM' implies paramagnetism

		Temperature (K)										
		150		RT		400		500		600		
Sample details		$H_{\rm c}$	М	$H_{\rm c}$	М	$H_{\rm c}$	М	$H_{\rm c}$	М	$H_{\rm c}$	М	
Undoped ZnO		5753.66	0.214	793.78	0.184	931.51	0.073	808.11	0.068	795.37	0.053	
Eu <sup>3+</sup> concentration	0.01 M%	5717.93	0.201	646.49	0.188	921.96	0.078	760.34	0.062	548.56	0.028	
	0.1 M% 0.25 M%	6091.87 5478.20	$\begin{array}{c} 0.240\\ 0.221\end{array}$	$566.07 \\ 546.17$	$0.190 \\ 0.189$	564.48 Nil	0.052 Nil	Nil PM	Nil PM	PM PM	PM PM	

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The peak at 590 nm due to the  ${}^5D_0 \rightarrow {}^7F_1$  transition is an allowed magnetic-dipole transition, if the Eu<sup>3+</sup> ion is situated in a symmetry center in the ZnO matrix. The electric-dipole transitions between the 4f<sup>6</sup> levels are strictly forbidden by the Laporte selection rule (equal parity) while the magnetic-dipole is allowed. Thus, the intensity ratio of  ${}^5D_0 \rightarrow {}^7F_2$  electric dipole transition to  ${}^5D_0 \rightarrow {}^7F_1$  magnetic-dipole transition known as symmetry ratio can provide information about the structural quality of the material.<sup>33,34</sup> The 1 : 10 symmetry ratio in our material indicates very low inversion from electric to magnetic dipole symmetry when the Eu<sup>3+</sup> ion is incorporated into hexagonal ZnO host by substitution in the Zn sub lattice and negligible emission of other Eu<sup>3+</sup> characteristic transitions (for example,  ${}^5D_0 \rightarrow {}^7F_0$  at ~580 nm;  ${}^5D_0 \rightarrow {}^7F_3$  at ~650 nm) that leads to efficient electric dipole transition leading to observed strong orange red emission at 618–

622 nm as shown in the inset of Fig. 2b (RHS). The observation of such strong green emission in undoped ZnO due to V<sub>o</sub> and orange red emission without the distinct background of defect emission band in Eu<sup>3+</sup> doped ZnO clearly suggests that there exists an energy transfer mechanism between the ZnO host and the Eu<sup>3+</sup> ions.<sup>30,35-37</sup>

**4.1.1 Defect mediated energy transfer.** Possible energy transfer mechanism responsible for the emission of undoped and  $Eu^{3+}$  doped ZnO NPs is shown in Fig. 3. In the case of undoped ZnO, following above band gap excitation, the carriers relax to the band edge of the conduction band, where they are rapidly trapped at the V<sub>o</sub> related defect state. On doping  $Eu^{3+}$  in ZnO lattice, a resonant energy transfer process, as shown in Fig. 3, takes place and the trapped carriers at V<sub>o</sub> could transfer their energy to the  $Eu^{3+}$  subsystem.<sup>37</sup> Almost negligible

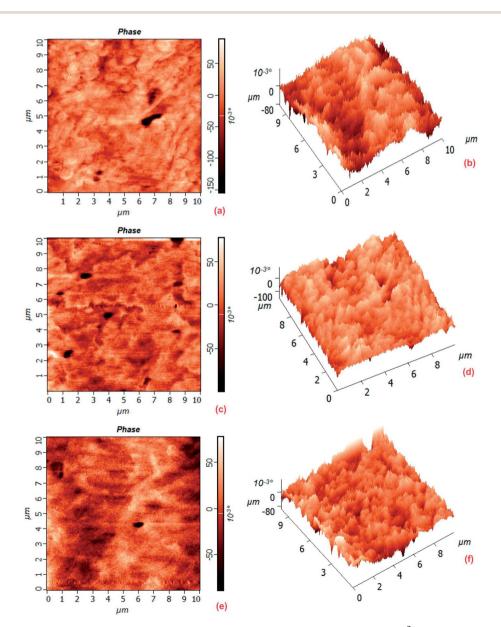


Fig. 6 MFM picture (2D and 3D) of pellet made of (a & b) undoped (c & d) 0.01 M% and (e & f) 0.1 M% of Eu<sup>3+</sup> doped ZnO NPs shows the presence of magnetic domain structure which confirms the internal ferromagnetism.

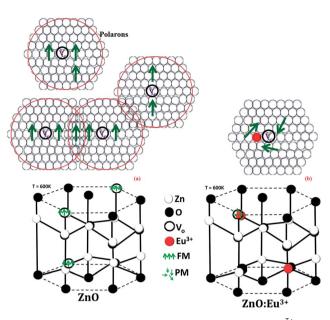


Fig. 7 Schematic diagram of the (a) undoped and (b)  $Eu^{3+}$  doped wurtzite structure of ZnO NPs shows the presence of oxygen vacancies V<sub>o</sub>, ferromagnetic (FM) and paramagnetic (PM) couplings along with formation of polarons.

absorption at 375 nm for Eu<sup>3+</sup> NPs compared to broad absorption peak observed at this level for undoped ZnO (Fig. 2c), due to radiative relaxation to lower defect levels and observation of peaks at 385 nm, and around 425 to 460 nm for Eu<sup>3+</sup> doped ZnO due to Eu<sup>3+</sup> transition levels, further confirmed that there is effective energy transfer between the host and activator ion. Following the non radiative process to lower energy state of Eu<sup>3+</sup>, as a final step of the energetic process, Eu<sup>3+</sup> ions trace the radiative transition path from <sup>5</sup>D<sub>0</sub> to <sup>7</sup>F<sub>2</sub>, resulting in the orange red emission.

#### 4.2 Results from magnetic studies

The temperature dependent *M*–*H* curves of undoped and Eu<sup>3+</sup> doped ZnO NPs from 150 to 600 K is shown in Fig. 4. The magnetization (*M*) value of undoped ZnO shows a rapid decrease with increase in temperature but the coercive field ( $H_c$ ) decreased up to RT from 150 K and further increased up to 400

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K and thereafter gradually decreased with increase in temperature up to 600 K (Table 1) which could be a result of the reduced thermal fluctuation and better spin alignment at low temperatures. The magnetization signal of undoped ZnO persists up to 600 K and shows  $H_c$  of 795.37 A m<sup>-1</sup> and M of 0.053 A m<sup>2</sup> kg<sup>-1</sup> as shown in the inset of Fig. 4a and Table 1, established the stability of FM above RT.

The *M*-*H* studies were carried out for lower (0.01 M%), medium (0.1 M%) and higher (0.25 M%) concentration of Eu<sup>3+</sup> to see the effect of doping on the FM behavior of ZnO lattice and the results are presented as Fig. 4b-d respectively. H<sub>c</sub> gradually decreased with increase in Eu<sup>3+</sup> concentration compared to undoped ZnO case, while maintaining M constant. The  $H_c$ drastically reduced at RT compared to 150 K and gradual decreasing trend with temperature and Eu<sup>3+</sup> doping in ZnO lattice. At 0.01 M%, the magnetization significantly reduced with temperature and the H<sub>c</sub> increased at 400 K compared to RT and gradually decreased with increase in temperature above 400 K (Table 1). In the 0.1 M%,  $H_c$  and M decreased with increase in temperature up to 400 K and FM is almost zero at 500 K and the paramagnetic response is observed at 600 K as shown in the inset of Fig. 4c and Table 1. The complete extinction of the FM observed at 400 K by increasing the Eu<sup>3+</sup> concentration to 0.25 M%, along with the appearance of paramagnetic character with further increase in temperature up to 600 K as shown in insets of Fig. 4d. This magnetic transition (ferromagnetic to paramagnetic) suggests that the high temperature is responsible for the rapid destruction of ferromagnetic coupling. Fig. 5 reveals the variation of magnetization as a function of temperature between 150 and 600 K at an applied DC magnetic field of 5000 Oe. Slightly decreased trend of magnetization observed for undoped and lower Eu<sup>3+</sup> concentration (0.001 M%) and notable magnetization drop observed at around 500 K for 0.1 M% Eu<sup>3+</sup> doped NPs (RHS of the inset). The magnetization falls sharply at 400 K and almost zero at 600 K for higher Eu<sup>3+</sup> concentration (0.25 M%) conclusively proves that role of Eu<sup>3+</sup> in FM to paramagnetism transition. The dM/dT curves (LHS of the inset) of 0.25 M% of Eu<sup>3+</sup> doped ZnO NPs shows an intercept at about 550 K indicating the Curie temperature. This falls in line with our earlier observation from the B vs. H studies (Table 1) which shows ferromagnetism to paramagnetism transition at this

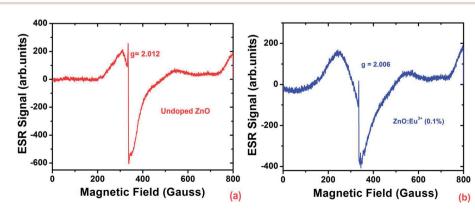


Fig. 8 EPR spectra of (a) undoped and (b) Eu<sup>3+</sup> doped (0.1 M%) ZnO NPs.

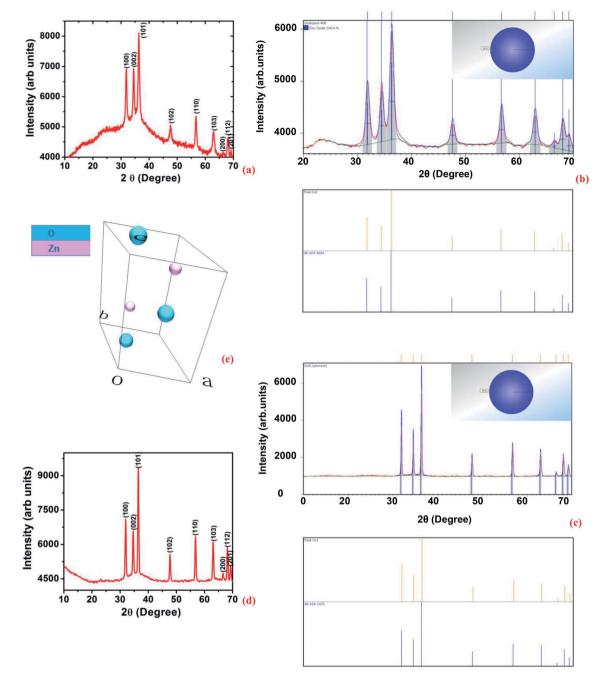


Fig. 9 Structural properties of ZnO:Eu<sup>3+</sup> NPs. XRD and Rietveld refinement pattern of the Undoped (a and b) and Eu<sup>3+</sup> (0.1 M%) doped ZnO NPs (c and d) shows purity and crystalline nature of the samples. (e) Unit cell of undoped ZnO shows the positions of zinc and oxygen.

temperature range. Extended analysis of the magnetic characteristics of ZnO: $Eu^{3+}$  by MFM show the formation of magnetic domains which establishes the fundamental origin of FM. The MFM image of undoped and  $Eu^{3+}$ doped ZnO NPs (Fig. 6) at RT reveals uniform and oriented distribution and the aligned magnetic domains are indicative of the magnetic interactions.<sup>38-40</sup>

**4.2.1 Correlation between V\_o and FM.** Despite several efforts, there is still no complete understanding of the origin of RTFM in oxide-based DMS materials, whether it is an extrinsic

effect due to direct interaction between the local moments in magnetic impurity clusters or it is indeed an intrinsic property caused by exchange coupling between the spins of the carriers and the local magnetic moments is not clear. Experimental results reported by various groups are quite diverse and hence, the underlying origin of RTFM in ZnO based DMS is still a topic of interest.<sup>41,42</sup> The possible reasons for the inconsistent results may be due to the creation and distribution of the different concentrations of defects and/or formation of secondary FM phases/metal clusters that are dependent on the growth methods

Table 2 The Rietveld refinement factors for undoped and  $Eu^{3+}$  doped ZnO NPs obtained from X-ray powder diffraction data

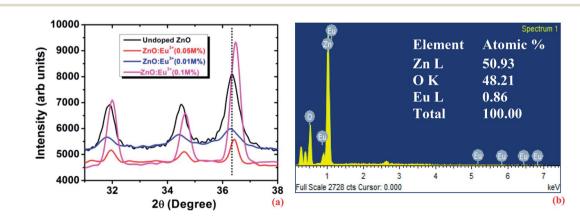
Parameters	Undoped ZnO	ZnO:Eu <sup>3+</sup> (0.1 M%)		
R expected $(R_{exp})$	2.3856	2.1017		
R profile $(R_p)$	1.9375	3.6224		
Weighted profile factor $(R_{wp})$	2.4094	4.3255		
Goodness of fit (S) $[(R_{wp})/(R_{exp})]$	1.0099	2.0581		

and processing conditions of sample synthesis methodologies. However, the fact that RTFM is observed in both undoped and Eu<sup>3+</sup> doped ZnO systems, helps to resolve the controversies related to the role of impurities in FM ordering in our system. The only possible contaminant could be the precursor for ZnO NPs synthesis is zinc acetate, with a claimed iron content less than (0.0001%) as the magnetic impurity. If in case this trace amount of iron is responsible to be the cause for the observed FM then the associated magnetization and coercive field would have been constant throughout the temperature range and this magnetic behavior would also exist in the Eu<sup>3+</sup> doped ZnO NPs. Our studies indicate that the magnetization and coercive field are both strongly dependant on the temperature and Eu<sup>3+</sup> concentration and along with observed phase transition (ferromagnetic to paramagnetic) is reason enough to clearly rule out the possibility of presence of any magnetic clusters.

The *M* vs. *T* studies also lend support to the above claim. The presence of  $V_o$  was confirmed by PL, EDS and XPS analysis (EDS, XPS studies are elaborated in the following section) and in trying to establish a correlation between  $V_o$  and the FM in ZnO system it is observed that  $V_o$  in undoped ZnO, enhances the defect related green emission as seen in the PL studies and the VSM studies show a maximum  $H_c$  and magnetization in undoped ZnO NPs at RT compared to Eu<sup>3+</sup> containing samples, which establishes that  $V_o$  is responsible for the observed FM. Decrease in coercive field and magnetization by increasing dopant concentration can be directly correlated to the decrease in  $V_o$  related green luminescence with increasing dopant concentration from PL studies and decreased intensity of  $O^{2-}$  ions in XPS

analysis for Eu<sup>3+</sup> doped samples compared with undoped ZnO NPs. Similar observations have been earlier reported in undoped<sup>42</sup> and Nd doped ZnO NPs.<sup>43</sup> Several theories proposed for defect induced FM44-46 like magnetic cations, carriers, and defects that can make up bound magnetic polarons (BMPs) could be responsible for the observed RTFM.<sup>44</sup> One such theory is related to the F<sup>+</sup> center exchange mechanism due to extended BMPs which overlap to create a spin-split impurity band. The F<sup>+</sup> centers are mainly the electrons in the singly occupied V<sub>o</sub> lying deep in the gap which could possibly influence ferromagnetic ordering. Uncontrolled formation of lattice defects can generate carriers that mediate FM and this mechanism supports the related RTFM induced by point defects such as Vo. Fig. 7 shows a schematic of the interaction in Zn and oxygen atoms, where defects such as Vo act as electron source. As the concentration of these electrons, which are lying in hydrogenic orbitals with characteristic Bohr radii is high; their individual orbits extend out into narrow impurity bands. Electrons interact with all magnetic ions that lie within their orbit. In the event of adequate magnetic spins, the electron is completely spin polarized. Furthermore, the magnetic moments have an indirect exchange interaction mediated by carriers, resulting in ferromagnetic ordering. In the case of doped material there are two phenomena. One is the introduction of Eu<sup>3+</sup> occupying the Zn<sup>2+</sup> position would result in reduction of Vo to maintain charge balance. This justifies the reduction in the ferromagnetic character with increasing Eu<sup>3+</sup> concentration. Secondly Eu<sup>3+</sup> by itself is a paramagnetic atom that explains for the ferromagnetic to paramagnetic transition as represented in these schematic.

To further substantiate this proposal; more convincing analysis of defect states was performed with EPR analysis. Fig. 8 shows the EPR results measured at RT for the undoped and Eu<sup>3+</sup> doped (0.1 M%) ZnO NPs. It can be seen that a single EPR signal appearing in both the samples suggests that similar type of paramagnetic defects are present in the lattice. According to earlier reports, such EPR signal is believed to be characteristic of FM in oxide nanostructures,<sup>47,48</sup> which has its origin in the paramagnetic V<sub>o</sub> with an unpaired electron.<sup>49</sup> EPR signals with the peak values of g = 2.021 for undoped and g = 2.006 for Eu<sup>3+</sup> doped ZnO have been attributed to chemisorbed oxygen.<sup>50</sup>



**Fig. 10** Incorporation of  $Eu^{3+}$  in ZnO lattice. Observed shift in XRD peak position (figure (a)) due to  $Eu^{3+}$  incorporation and  $Eu^{3+}$  detected in EDS analysis [figure (b); ZnO: $Eu^{3+}$  (0.1 M%)] confirms the incorporation of  $Eu^{3+}$  in ZnO lattice.

Chemisorbed oxygen was reported to result in a very broad feature between g = 2.005 to 2.05 which is in agreement with the broad peak observed in this range for our RT EPR measurements. As expected, the intensity of EPR signal becomes weaker in Eu<sup>3+</sup> doped samples compared with undoped ZnO, indicating that the concentration of the V<sub>o</sub> decreases in Eu<sup>3+</sup> doped ZnO, which is in agreement with the PL, VSM and XPS results.

# 4.3 Structural, morphological and compositional evaluations

Fig. 9 shows the XRD patterns of undoped (Fig. 9a) and  $Eu^{3+}$  doped (0.1 M%) ZnO NPs (Fig. 9d). The peaks are sharp

indicating the highly crystalline nature of the synthesized materials. The observed patterns were fitted using the Rietveld method considering the  $P6_3mc$  space group with a hexagonal structure [Fig. 9b (undoped ZnO) and Fig. 9c (ZnO:Eu<sup>3+</sup>)]. It can be seen that the profiles for observed and calculated data are in perfect agreement. The refinement details and reliability factors obtained through Rietveld analysis are given in Table 2, where the goodness of fit (*S*) comes out to be around 1.0099 for undoped ZnO and 2.0581 for ZnO:Eu<sup>3+</sup>. The structure of the undoped and Eu<sup>3+</sup> doped ZnO NPs shown in the corresponding insets of the Fig. 9b and c show only ZnO structure, confirming the purity of the NPs. Fig. 9e shows the unit cell of the

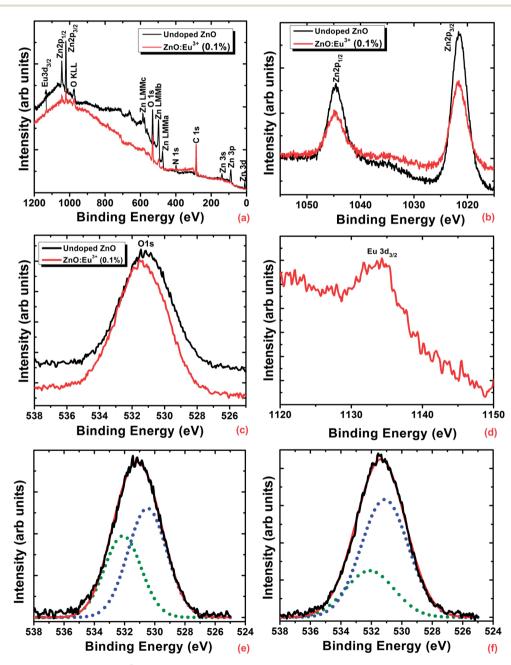


Fig. 11 Binding energy positions of ZnO: $Eu^{3+}$  from XPS spectra (a) survey scan (b) Zn core level (c) oxygen core level and (d)  $Eu^{3+}$  core level region and deconvoluted oxygen core level spectrum of (e) undoped and (f) 0.1 M%  $Eu^{3+}$  doped ZnO NPs confirmed the incorporation of dopant and presence of V<sub>o</sub>.

ZnO NPs where the position and direction of Zn and oxygen ions can be seen. To determine the alterations in crystal parameters, the prominent (100), (002), (101) peaks of prepared NPs were analyzed (Fig. 10a) and results indicate the shift in peak positions towards higher  $2\theta$  because of the tensile strain caused by the doping of Eu<sup>3+</sup> with a comparatively larger ionic radius (0.1087 nm), replacing the  $Zn^{2+}$  (0.088 nm), in ZnO lattice.<sup>51</sup> The hexagonal wurtzite structure has been observed in all the samples where the peaks were well matched with the JCPDS data card no. 36-1451. No separate peaks due to Eu<sup>3+</sup> or any other impurity confirms the purity of ZnO within the detection limits of the XRD. The mean crystallite size of these NPs estimated by applying the Scherrer's formula to the major diffraction peaks is about 30-35 nm. The EDS spectrum of Eu<sup>3+</sup> doped ZnO (0.1 M%) shown in Fig. 10b reveals the presence of only Zn, O and Eu<sup>3+</sup> elements, confirming the absence of any other impurity. The atomic percentage of the elements, Zn, O and Eu<sup>3+</sup> are 50.93, 48.21% and 0.86% respectively, reflects the oxygen deficiency and incorporation of  $Eu^{3+}$  in the sample.

XPS analysis was employed to further determine presence of Eu<sup>3+</sup> and confirm its oxidation state in ZnO lattice and to determine surface chemical composition. From Fig. 11a, peaks assigned to core levels of Zn 2p, Zn 3p, O 1s and Eu 3d are identified. Fig. 11b is the Zn 2p core level spectra in undoped and Eu<sup>3+</sup> doped ZnO NPs showing the Zn 2p spin orbit split doublet at 1044.5 and 1021.4 eV confirming the Zn<sup>2+</sup> in the zinc oxide.<sup>52,53</sup> O 1s core level spectra of undoped and Eu<sup>3+</sup> doped ZnO along with deconvolution spectra shown in Fig. 11c, e and f have two-peak contribution. The first peak centered at 530.9 nm can be assigned to the  $O^{2-}$ ions in the hexagonal structure of ZnO lattice surrounded by zinc atoms.<sup>54</sup> The second binding energy peak centered at 532.4 is associated with  $O^{2-}$  ions that are in oxygen deficient regions (V<sub>o</sub>) within the matrix of ZnO.<sup>55</sup> From the comparative studies, it is found that the V<sub>o</sub> peak decreased in Eu<sup>3+</sup>

doped NPs compared to undoped ZnO and this indicates a gradual decreasing of defect concentration in doped NPs compared to undoped ZnO which is consistent with the PL analysis. The core level XPS spectra of Eu 3d gives a single intense peak at 1134.7 eV due to Eu  $3d_{3/2}$ , indicating the oxidation state of Eu<sup>3+</sup> ions to be primarily trivalent for the ZnO:Eu<sup>3+</sup> NPs.<sup>56</sup>

The surface morphology of the ZnO:Eu<sup>3+</sup> NPs were examined using FE-SEM. All the images in Fig. 12 show the nano rod and plate like structure and the obtained doped NPs undergo significant morphological changes because of the Eu<sup>3+</sup> incorporation into ZnO lattice. Undoped ZnO shows plate like formation with rough surface (Fig. 12a) with thickness of about 800 nm and width about 60-80 nm indicating a preferential growth. The ZnO doped with lower Eu<sup>3+</sup> concentration (0.025 M%) showed nanorods with smooth surface and decreased length compared to undoped ZnO without any preferred orientation. A further increase of Eu<sup>3+</sup> concentration (0.1 M%), smoothened the nanorods and hexagonal cross sections were visible towards the end of the nanorods as indicated by the arrow in the picture. To elaborate on the morphology change, it can be seen that with the introduction of Eu<sup>3+</sup> into ZnO lattice, the growth along *c*-axis is affected and the length of nanorods is decreased, which gives the evidence of hindered growth of crystal along c-axis.

The growth mechanism of NPs can be explained on the basis of the polar surfaces of ZnO. The hexagonal wurtzite structure of ZnO comprises of sequentially alternating planes of tetrahedrally coordinated  $O^{2-}$  and  $Zn^{2+}$  ions, piling up along the *c*axis.<sup>57</sup> The ions create positively charged (0001)-Zn and negatively charged (000–1)-O polar surfaces.<sup>58</sup> The incorporation of Eu<sup>3+</sup> into ZnO matrix can produce planar defects along (0001) plane disrupting the growth process resulting in rods of reduced length. EDS elemental mapping indicated that the samples were composed of only Zn (Fig. 12d), O (Fig. 12e), and Eu<sup>3+</sup> uniformly distributed (Fig. 12f).

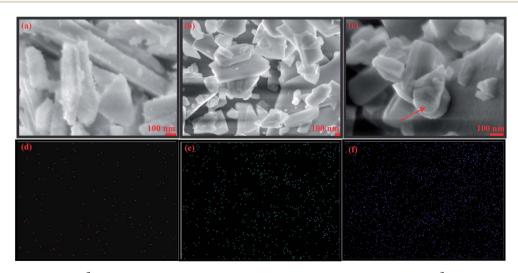


Fig. 12 Morphology of the ZnO:Eu<sup>3+</sup> NPs. FESEM images of (a) undoped and (b) 0.025 M% and (c) 0.1 M% of Eu<sup>3+</sup> doped ZnO NPs. EDS elemental mapping showing (d) Zn (e) O and (f) Eu<sup>3+</sup> distribution in ZnO sample.

## 5. Conclusions

Well crystallized undoped and Eu3+ doped ZnO NPs were prepared by simple SCT technique. PL studies of undoped ZnO exhibit prominent green band emission (536 nm) due to radiative recombination of a photo-generated hole with an electron attributed to Vo. Eu3+ doped ZnO NPs, under the typical UV excitation of ZnO host, the direct energy transfer from ZnO host to Eu<sup>3+</sup> ions, along with a quenching of broad defect emission of ZnO was observed which possibly arises due to the formation of intrinsic trapping centers due to the substitution of Zn<sup>2+</sup> by Eu<sup>3+</sup> in the NPs. The magnetic studies show a stable FM at RT with  $H_c$ of 793.78 A m<sup>-1</sup> and magnetization of 0.184 A m<sup>2</sup> kg<sup>-1</sup> for undoped ZnO NPs. The temperature dependent magnetization studies (150-600 K) show stable FM well above RT for undoped ZnO NPs that gradually decreased by introducing the dopant and the observed phase transformation from ferromagnetic to paramagnetic observed at higher Eu<sup>3+</sup> concentration supports our theory on the origin of defects in high temperature FM observed in undoped oxide semiconductors. The dM/dT gives a Curie temperature of about 550 K that falls in line with the ferromagnetic to paramagnetic transition observed in the B vs. H studies. The EPR analysis further confirmed the origin of defects could be  $V_0$  and its decrease by increasing Eu<sup>3+</sup> concentration leads to reduced in FM. This study also directs us to propose a method for designing materials with tunable FM by appropriate dopant.

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